Supporting Information

Interference-Driven Structural Colors in Anodized Niobium Oxide Thin Films: Mechanism Analysis and Multi-Chromatic Optical Response

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Fig. S1. Linear relationship between R/(G + B) and anodic oxidation time in different oxide films measured by ColorPiker application.

| | 1 min | 2 min | 3 min | 4 min | 5 min | 6 min | 7 min | 8 min | 9 min | 10 min |
|---------|--------|--------|--------|--------|--------|--------|--------|--------|--------|--------|
| R | 159 | 150 | 146 | 157 | 168 | 208 | 197 | 201 | 216 | 252 |
| G | 189 | 170 | 166 | 172 | 174 | 207 | 197 | 199 | 209 | 238 |
| В | 199 | 166 | 162 | 160 | 139 | 134 | 121 | 112 | 81 | 47 |
| R/(G+B) | 0.4098 | 0.4464 | 0.4451 | 0.4729 | 0.5367 | 0.6100 | 0.6195 | 0.6463 | 0.7448 | 0.8842 |

Table. S1. R/(G+B) values in different oxide films measured by the ColorPiker application



Fig. S2. Nb₂O₅ films formed by anodization at different voltages (10–90 V): (a) Digital images of the samples, (b) Relationship between R/(G + B) and the anodizing voltage, (c) Sample RGB values measured using a smartphone-based colorimetry method.



Fig. S3. EDS spectra of the films synthesized with anodization times of 2 min (a)and 7 min (b). (c) XRD patterns for anodizing times of 15 min and 60 min.



Fig. S4. SEM images of the samples synthesized under different anodic oxidation voltages: (a)20V(b)35V(c)50V



Fig. S5. Direct and indirect bandgap diagrams of samples with different anodizing times, (a) 20s, (b) 30s, (c) 1min, (d) 2min, (e) 3min, (f) 4min, (g) 5min, (h) 7min, (i) 9min